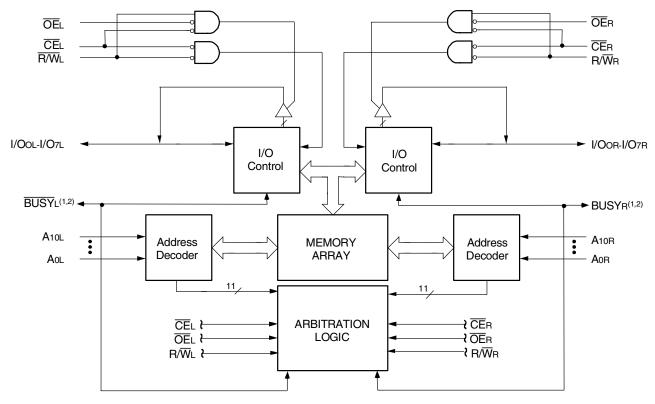
	HIGH SPEED 2K x 8 DUAL PORT STATIC RAM	IDT7132SA/LA IDT7142SA/LA
Features • High-speed access - Commercial: 20/25/35/55/100ns (max.) - Industrial: 25ns (max.) - Military: 25/35/55/100ns (max.) • Low-power operation - IDT7132/42SA Active: 325mW (typ.) Standby: 5mW (typ.) - IDT7132/42LA Active: 325mW (typ.) Standby: 1mW (typ.)	<ul> <li>bits using SLAVE IDT7142</li> <li>On-chip port arbitration log</li> <li>BUSY output flag on IDT713</li> <li>Battery backup operation –</li> <li>TTL-compatible, single 5V ±</li> <li>Available in 48-pin DIP, LCC packages</li> <li>Military product compliant t</li> </ul>	22; BUSY input on IDT7142 -2V data retention (LA only) 10% power supply C and Flatpack, and 52-pin PLCC to MIL-PRF-38535 QML e (-40°C to +85°C) is available for

Functional Block Diagram



2692 drw 01

- IDT7132 (MASTER): BUSY is open drain output and requires pullup resistor of 270Ω. IDT7142 (SLAVE): BUSY is input.
- 2. Open drain output: requires pullup resistor of 270Ω.

#### Description

The IDT7132/IDT7142 are high-speed 2K x 8 Dual-Port Static RAMs. The IDT7132 is designed to be used as a stand-alone 8-bit Dual-Port RAM or as a "MASTER" Dual-Port RAM together with the IDT7142 "SLAVE" Dual-Port in 16-bit-or-more word width systems. Using the IDTMASTER/ SLAVE Dual-Port RAM approach in 16-or-more-bit memory system applications results in full-speed, error-free operation without the need for additional discrete logic.

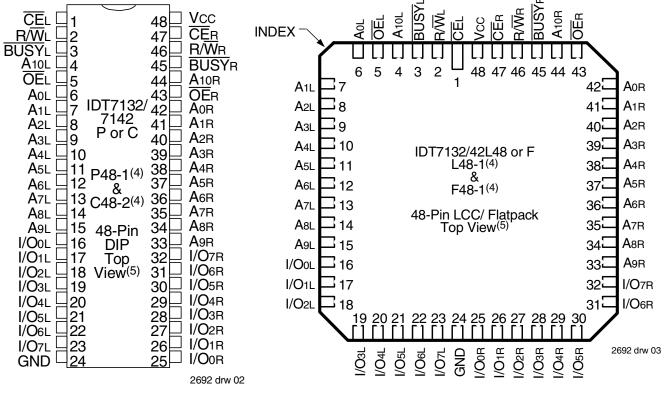
Both devices provide two independent ports with separate control, address, and I/O pins that permit independent, asynchronous access for reads or writes to any location in memory. An automatic power down feature, controlled by CE permits the on-chip circuitry of each port to enter

a very low standby power mode.

Fabricated using IDT's CMOS high-performance technology, these devices typically operate on only 325mW of power. Low-power (LA) versions offer battery backup data retention capability, with each Dual-Port typically consuming 200µW from a 2V battery.

The IDT7132/7142 devices are packaged in a 48-pin sidebraze or plastic DIPs, 48-pin LCCs, 52-pin PLCCs, and 48-lead flatpacks. Military grade product is manufactured in compliance with the latest revision of MIL-PRF-38535 QML, making it ideally suited to military temperature applications demanding the highest level of performance and reliability.

## Pin Configurations<sup>(1,2,3)</sup>



#### NOTES:

- 1. All Vcc pins must be connected to the power supply.
- 2. All GND pins must be connected to the ground supply.
- P48-1 package body is approximately .55 in x 2.43 in x .18 in. C48-2 package body is approximately .62 in x 2.43 in x .15 in. L48-1 package body is approximately .57 in x .57 in x .68 in. F48-1 package body is approximately .75 in x .75 in x .11 in.
- 4. This package code is used to reference the package diagram.
- 5. This text does not indicate orientation of the actual part-marking.

## Capacitance<sup>(1)</sup> (TA = $+25^{\circ}C, f = 1.0MHz$ )

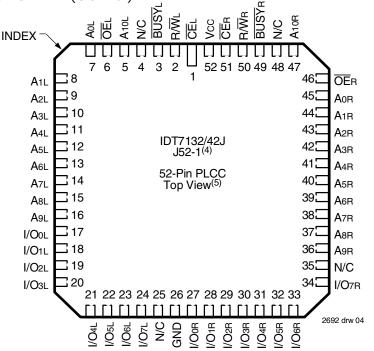
Symbol	Parameter	Conditions <sup>(2)</sup>	Max.	Unit
Cin	Input Capacitance	VIN = 3dV	11	рF
Соит	Output Capacitance	Vout = 3dV	11	pF
				2692 thi 00

NOTES:

1. This parameter is determined by device characterization but is not production tested.

3dV represents the interpolated capacitance when the input and output signals switch from 3V to 0V.

# Pin Configurations<sup>(1,2,3)</sup> (con't.)



#### NOTES:

1. All Vcc pins must be connected to the power supply.

2. All GND pins must be connected to the ground supply.

3. Package body is approximately .75 in x .75 in x .17 in.

4. This package code is used to reference the package diagram.

5. This text does not indicate orientation of the actual part-marking.

Symbol	Rating	Commercial & Industrial	Military	Unit
VTERM <sup>(2)</sup>	Terminal Voltage	-0.5 to +7.0	-0.5 to +7.0	V
	with Respect to GND	0.0 10 17.0	0.0 10 17.0	•
TBIAS	Temperature Under Bias	-55 to +125	-65 to +135	٥C
Tstg	Storage Temperature	-65 to +150	-65 to +150	٥C
Ιουτ	DC Output Current	50	50	mA

### Absolute Maximum Ratings<sup>(1)</sup>

#### NOTES:

 Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of the specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

 VTERM must not exceed Vcc + 10% for more than 25% of the cycle time or 10ns maximum, and is limited to ≤ 20mA for the period of VTERM ≥ Vcc + 10%.

### Recommended Operating Temperature and Supply Voltage<sup>(1,2)</sup>

Grade	Ambient Temperature	GND	Vcc
Military	-55°C to+125°C	0V	5.0V <u>+</u> 10%
Commercial	$0^{\circ}C$ to $+70^{\circ}C$	0V	5.0V <u>+</u> 10%
Industrial	-40°C to +85°C	0V	5.0V <u>+</u> 10%
			2692 tbl 02

NOTES:

2692 tbl 01

2072 101

2692 tbl 03

1. This is the parameter TA. This is the "instant on" case temperature.

Industrial temperature: for specific speeds, packages and powers contact your sales office.

# Recommended DC Operating Conditions

Symbol	Parameter	Min.	Тур.	Мах.	Unit
Vcc	Supply Voltage	4.5	5.0	5.5	V
GND	Ground	0	0	0	V
VIH	Input High Voltage	2.2	—	6.0 <sup>(2)</sup>	V
VIL	Input Low Voltage	-0.5(1)	_	0.8	V

NOTES:

1. VIL (min.) = -1.5V for pulse width less than 10ns.

2. VTERM must not exceed Vcc + 10%.

Military, Industrial and Commercial Temperature Ranges

# DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range<sup>(1,5,8)</sup> (Vcc = 5.0V ± 10%)

					7142	X20 <sup>(2)</sup> X20 <sup>(2)</sup> I Only	7142 Com	X25 <sup>(7)</sup> X25 <sup>(7)</sup> 'I, Ind litary	714: Con	2X35 2X35 n'I & itary	
Symbol	Parameter	Test Condition	Versi	on	Тур.	Мах.	Тур.	Мах.	Тур.	Мах.	Unit
Icc	Dynamic Operating Current (Both Ports Active)	$\overline{CEL} = \overline{CER} = VIL,$ Outputs Disabled $f = fMAX^{(3)}$	COM'L	SA LA	110 110	250 200	110 110	220 170	80 80	165 120	mA
		I = IMAX <sup>(0)</sup>	MIL & IND	SA LA			110 110	280 220	80 80	230 170	
ISB1	$ \begin{array}{l} \mbox{Standby Current} \\ \mbox{(Both Ports - TTL} \\ \mbox{Level Inputs)} \end{array} \  \  \  \  \  \  \  \  \  \  \  \  \$	$\label{eq:cell} \overline{CE}L = \overline{CE}R = VIH, \\ f = fMAX^{(3)}$	COM'L	SA LA	30 30	65 45	30 30	65 45	25 25	65 45	mA
			MIL & IND	SA LA			30 30	80 60	25 25	80 60	
ISB2	Standby Current (One Port - TTL	$\overline{CE}^*A^* = VIL \text{ and } \overline{CE}^*B^* = VIH^{(6)}$ Active Port Outputs Disabled	COM'L	SA LA	65 65	165 125	65 65	150 115	50 50	125 90	mA
	Level Inputs)	f=fMAX <sup>(3)</sup>	MIL & IND	SA LA			65 65	160 125	50 50	150 115	
ISB3	Full Standby Current (Both Ports - All	$\overline{CE}L$ and $\overline{CE}R \geq$ VCC -0.2V VIN $\geq$ VCC -0.2V or VIN $\leq$ 0.2V, f = 0(4)	COM'L	SA LA	1.0 0.2	15 5	1.0 0.2	15 5	1.0 0.2	15 4	mA
	CMOS Level Inputs)		MIL & IND	SA LA			1.0 0.2	30 10	1.0 0.2	30 10	
ISB4	Full Standby Current (One Port - All CMOS Louis Insuite)	ort - All $VIN \ge VCC - 0.2V \text{ or } VIN \le 0.2V$	COM'L	SA LA	60 60	155 115	60 60	145 105	45 45	110 85	mA
	CMOS Level Inputs)	Active Port Outputs Disabled $f = f_{MAX}^{(3)}$	MIL & IND	SA LA			60 60	155 115	45 45	145 105	

					714: Con	2X55 2X55 n'I & itary	7142 Con	X100 X100 n'l & itary	
Symbol	Parameter	Test Condition	Versi	on	Тур.	Max.	Тур.	Max.	Unit
Icc	Dynamic Operating Current (Both Ports Active)	CEL = CER = VIL, Outputs Disabled f = fMAX <sup>(0)</sup>	COM'L	SA LA	65 65	155 110	65 65	155 110	mA
		MIL & IND	SA LA	65 65	190 140	65 65	190 140		
ISB1	B1 Standby Current $\overline{CE}L = \overline{CE}R = VH$ , (Both Ports - TTL $f = fMAX^{(0)}$ Level Inputs)	COM'L	SA LA	20 20	65 35	20 20	55 35	mA	
	Level inputs)		MIL & IND	SA LA	20 20	65 45	20 20	65 45	
ISB2	Standby Current (One Port - TTL	$\overline{CE}^{*}A^{*} = VIL \text{ and } \overline{CE}^{*}B^{*} = VIH^{(6)}$ Active port Outputs Disabled	COM'L	SA LA	40 40	110 75	40 40	110 75	mA
	Level Inputs)	f=fmax <sup>(3)</sup>	MIL & IND	SA LA	40 40	125 90	40 40	125 90	
ISB3	Full Standby Current (Both Ports - All	$\overline{CEL}$ and $\overline{CER} \ge VCC$ -0.2V VIN $\ge VCC$ -0.2V or VIN $\le 0.2V$ , f = 0 <sup>(4)</sup>	COM'L	SA LA	1.0 0.2	15 4	1.0 0.2	15 4	mA
	CMOS Level Inputs)		MIL & IND	SA LA	1.0 0.2	30 10	1.0 0.2	30 10	
ISB4	Full Standby Current (One Port - All	CE'A" ≤ 0.2V and CE"B" ≥ Vcc -0.2V <sup>(6)</sup> VIN ≥ Vcc - 0.2V or VIN ≤ 0.2V	COM'L	SA LA	40 40	100 70	40 40	95 70	mA
	CMOS Level Inputs)	Active Port Outputs Disabled $f = f_{MAX}^{(0)}$	MIL & IND	SA LA	40 40	110 85	40 40	110 80	

2692 tbl 04b

2692 tbl 04a

NOTES:

1. 'X' in part numbers indicates power rating (SA or LA).

2. PLCC Package only

- 3. At f = fMax, address and control lines (except Output Enable) are cycling at the maximum frequency read cycle of 1/tRc, and using "AC TEST CONDITIONS" of input levels of GND to 3V.
- 4. f = 0 means no address or control lines change. Applies only to inputs at CMOS level standby.
- 5. Vcc = 5V, TA=+25°C for Typ and is not production tested. Vcc DC = 100mA (Typ)
- 6. Port "A" may be either left or right port. Port "B" is opposite from port "A".

7. Not available in DIP packages.

<sup>8.</sup> Industrial temperature: for specific speeds, packages and powers contact your sales office.

Military, Industrial and Commercial Temperature Ranges

2692 tbl 05

## DC Electrical Characteristics Over the Operating Temperature Supply Voltage Range ( $Vcc = 5.0V \pm 10\%$ )

				7132SA 7142SA		7132LA 7142LA		
Symbol	Parameter	Test Conditions	Min.	Мах.	Min.	Max.	Unit	
Lu	Input Leakage Current <sup>(1)</sup>	$V_{CC} = 5.5V,$ $V_{IN} = 0V$ to $V_{CC}$		10	_	5	μA	
Ilo	Output Leakage Current	$\frac{V_{CC}}{CE} = 5.5V,$ $\frac{V_{CE}}{CE} = V_{IH}, V_{OUT} = 0V \text{ to } V_{CC}$	-	10	_	5	μA	
Vol	Output Low Voltage	Iol = 4mA	_	0.4	-	0.4	V	
Vol	Open Drain O <u>utput</u> Low Voltage (BUSY)	lol = 16mA	—	0.5	I	0.5	v	
Vон	Output High Voltage	Юн = -4mA	2.4	_	2.4	_	V	

NOTE:

1. At Vcc  $\leq$  2.0V leakages are undefined.

### Data Retention Characteristics (LA Version Only)

Symbol	Parameter	Test Con	Test Condition			Мах.	Unit	
Vdr	Vcc for Data Retention	Vcc = 2.0V	Vcc = 2.0V		_		V	
ICCDR	Data Retention Current	CE ≥ Vcc -0.2V	Mil. & Ind.	_	100	4000	μA	
		Vin $\geq$ Vcc -0.2V or	Com'l.	—	100	1500	μA	
tcdr <sup>(3)</sup>	Chip Deselect to Data Retention Time	Vin <u>&lt;</u> 0.2V		0	_	_	ns	
tR <sup>(3)</sup>	Operation Recovery Time			trc <sup>(2)</sup>	_	_	ns	
	2692							

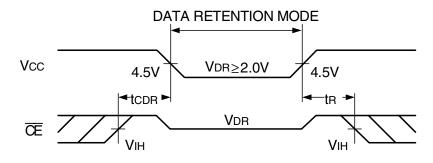
NOTES:

1. Vcc = 2V, TA = +25°C, and is not production tested.

2. tRc = Read Cycle Time

3. This parameter is guaranteed but not production tested.

## Data Retention Waveform



2692 drw 05

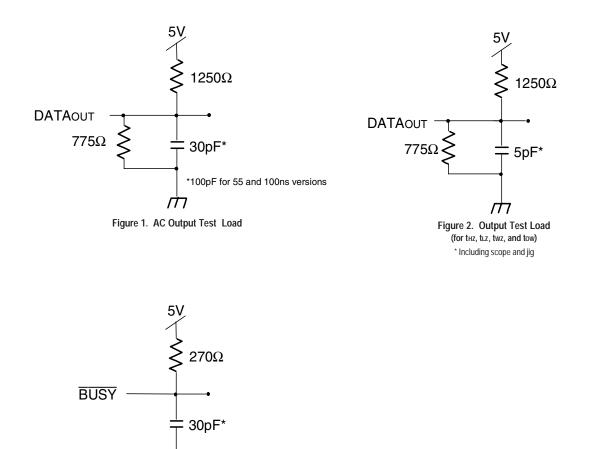
Military, Industrial and Commercial Temperature Ranges

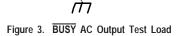
2692 drw 06

## AC Test Conditions

Input Pulse Levels	GND to 3.0V
Input Rise/Fall Times	3ns Max.
Input Timing Reference Levels	1.5V
Output Reference Levels	1.5V
Output Load	Figures 1, 2, and 3

2692 tbl 07





\*100pF for 55 and 100ns versions

## AC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range<sup>(3,5)</sup>

		7132X20 <sup>(2)</sup> 7132X25 <sup>(2)</sup> 7142X20 <sup>(2)</sup> 7142X25 <sup>(2)</sup> Com'l Only Com'l, In & Militar		X25 <sup>(2)</sup> 'I, Ind	<sup>(2)</sup> 7142X35 nd Com'l &			
Symbol	Parameter	Min.	Мах.	Min.	Max.	Min.	Max.	Unit
READ CY	CLE							
tRC	Read Cycle Time	20		25		35	—	ns
taa	Address Access Time		20	١	25		35	ns
<b>t</b> ACE	Chip Enable Access Time		20		25		35	ns
taoe	Output Enable Access Time		11	I	12		20	ns
tон	Output Hold from Address Change	3		3		3	—	ns
tLΖ	Output Low-Z Time <sup>(1,4)</sup>	0		0	_	0	—	ns
tHZ	Output High-Z Time <sup>(1,4)</sup>		10		10		15	ns
tPU	Chip Enable to Power Up Time <sup>(4)</sup>	0	_	0		0	—	ns
tPD	Chip Disable to Power Down Time <sup>(4)</sup>	_	20		25		35	ns

2692 tbl 08a

2692 tbl 08b

		7132X55 7142X55 Com'l & Military		7132X100 7142X100 Com'l & Military		
Symbol	Parameter	Min. Max.		Min.	Мах.	Unit
READ CYC	LE					
tRC	Read Cycle Time	55		100		ns
taa	Address Access Time		55		100	ns
tace	Chip Enable Access Time		55		100	ns
taoe	Output Enable Access Time		25	_	40	ns
tон	Output Hold from Address Change	3		10		ns
tLz	Output Low-Z Time <sup>(1,4)</sup>	5		5		ns
tHZ	Output High-Z Time <sup>(1,4)</sup>		25		40	ns
tPU	Chip Enable to Power Up Time <sup>(4)</sup>	0		0	I	ns
tPD	Chip Disable to Power Down Time <sup>(4)</sup>	_	50		50	ns

NOTES:

1. Transition is measured 0mV from Low or High-Impedance Voltage Output Test Load (Figure 2).

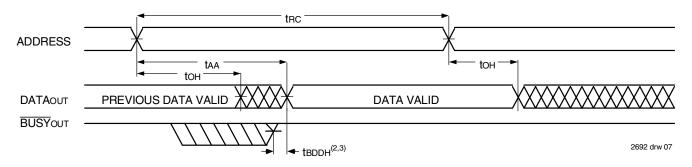
2. PLCC package only.

3. 'X' in part numbers indicates power rating (SA or LA).

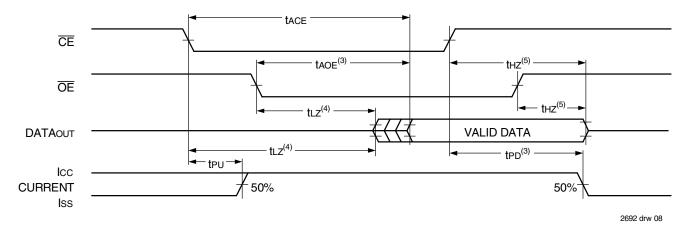
4. This parameter is guaranteed by device characterization, but is not production tested.

5. Industrial temperature: for specific speeds, packages and powers contact your sales office.

Timing Waveform of Read Cycle No. 1, Either Side<sup>(1)</sup>



# Timing Waveform of Read Cycle No. 2, Either Side<sup>(1)</sup>



- 1.  $R\overline{M} = V_{IH}$ ,  $\overline{CE} = V_{IL}$ , and is  $\overline{OE} = V_{IL}$ . Address is valid prior to the coincidental with  $\overline{CE}$  transition LOW.
- 2. tbbb delay is required only in the case where the opposite port is completing a write operation to the same address location. For simultaneous read operations, BUSY has no relationship to valid output data.
- 3. Start of valid data depends on which timing becomes effective last tAOE, tACE, tAA, and tBDD.
- 4. Timing depends on which signal is asserted last, OE or CE.
- 5. Timing depends on which signal is de-asserted first,  $\overline{OE}$  or  $\overline{CE}$ .

2692 tbl 10

## AC Electrical Characteristics Over the Operating Temperature Supply Voltage Range<sup>(5,6)</sup>

Matrix CVCLE         Value			7132X20 <sup>(2)</sup> 7142X20 <sup>(2)</sup> Com'l Only		7132X25 <sup>(2)</sup> 7142X25 <sup>(2)</sup> Com'l, Ind & Military		7132X35 7142X35 Com'l & Military			
tw         Chip Enable to End-of-Write         15          20          30          n           tw         Address Valid to End-of-Write         15          20          30          n           ts         Address Setup Time         0          15          20          30          n           tw         Write Pulse Width <sup>(4)</sup> 15          15          15          15          16          10          10          15          17         15         1          16         15          16         16          10          10          15         16          10          10          15         16         16         0         16          10          10          16         16          10          17         16         16         16         16         16         16         16         16         16         16         16<	Symbol	Parameter Min. Max.				Max.	Min.	Max.	Unit	
tw         Chip Enable to End-of-Write         15          20          30          n           tw         Address Valid to End-of-Write         15          20          30          n           ts         Address Setup Time         0          15          20          30          n           tw         Write Pulse Width <sup>(4)</sup> 15          15          15          15          16          10          10          15          17         15         1          16         15          16         16          10          10          15         16          10          10          15         16         16         0         16          10          10          16         16          10          17         16         16         16         16         16         16         16         16         16         16         16<	NRITE CYCLI	Ξ								
Iww         Address Valid to End-of-Write         15          20          30          n           tss         Address Setup Time         0          0          0          0          0          n           twp         Write Pulse Width <sup>(1)</sup> 15          0          15          15          15          10          10          10          10          15          15         1         15         1         15         1         15         1         15         1         15         1         15         1         15         1         15         1         15         1         15         1         15         1         15         1         15         1         15         1         15         1         15         1         15         1         16         10          15         1         16         10         1         15         16         16         16         16         16         16         16 <td>twc</td> <td>Write Cycle Time<sup>(3)</sup></td> <td>20</td> <td>_</td> <td>25</td> <td></td> <td>35</td> <td></td> <td>ns</td>	twc	Write Cycle Time <sup>(3)</sup>	20	_	25		35		ns	
hs         Address Set-up Time         0          0          0          n           hw         Write Pulse Width <sup>(0)</sup> 15          15          15          n           hw         Write Recovery Time         0          10          10          15          n           hw         Data Valid to End-of-Write         10          10	tew	Chip Enable to End-of-Write	15	_	20		30		ns	
Image         Write Puise Width <sup>(4)</sup> 15          15          25          nm           twice         Write Recovery Time         0          0          0          nm           twice         Data Valid to End of-Write         0          10 <t< td=""><td>taw</td><td>Address Valid to End-of-Write</td><td>15</td><td>-</td><td>20</td><td></td><td>30</td><td>_</td><td>ns</td></t<>	taw	Address Valid to End-of-Write	15	-	20		30	_	ns	
Image         Write Recovery Time         0          0          0          ne           IDW         Data Valid to End of-Write         10          12          15          ne           bz         Output High-Z Time <sup>(1)</sup> 10          100          100          100          100          100          100          100          100          100          100          100          100	tas	Address Set-up Time	0		0		0		ns	
bw         Data Valid to End-of-Write         10          12          15          ne           biz         Output High-Z Time <sup>(1)</sup> 10         10          10         10          10         10          10         10          10         10          10         10          <	twp	Write Pulse Width <sup>(4)</sup>	15		15		25		ns	
Itz       Output High-Z Time <sup>(1)</sup> 10       10       10	twr	Write Recovery Time	0	-	0		0	_	ns	
brain         Data Hold Time         0          0          0          n           tvz         Write Enable to Output in High-Z <sup>(1)</sup> 10          10          10          10          10          15         ns           tow         Output Active from End-of-Write <sup>(1)</sup> 0          0          0          0          10 <td>tow</td> <td>Data Valid to End-of-Write</td> <td>10</td> <td> </td> <td>12</td> <td></td> <td>15</td> <td></td> <td>ns</td>	tow	Data Valid to End-of-Write	10		12		15		ns	
twz         Write Enable to Output in High-Z <sup>(1)</sup> 10          10 <t< td=""><td>tHZ</td><td>Output High-Z Time<sup>(1)</sup></td><td>_</td><td>10</td><td></td><td>10</td><td>_</td><td>15</td><td>ns</td></t<>	tHZ	Output High-Z Time <sup>(1)</sup>	_	10		10	_	15	ns	
tow         Oulput Active from End-of-Write <sup>(1)</sup> 0         —         0         —         0         —         0         —         0         —         122235           7132X55 7142X55 Com'l & Military         7132X55 7142X100 Com'l & Military         7132X55 7142X100 Com'l & Military         7132X100 7142X100 Com'l & Military         7132X100 7142X10 7142X100 7142X100 7142X100 7142X10 7140 7140 7140 7140 7140 7140 7140 71	tdн	Data Hold Time	0		0		0		ns	
SymbolParameter2692 HSymbolParameter $7132X55$ 7142X55 Com'l & Military $7132X100$ Com'l & Military $7132X100$ Com'l & Military $7132X100$ Com'l & Military $7142X100$ Com'l & Military $7142X100$ Com'l & Military $Max$ Max <td>twz</td> <td>Write Enable to Output in High-Z<sup>(1)</sup></td> <td></td> <td>10</td> <td></td> <td>10</td> <td>_</td> <td>15</td> <td>ns</td>	twz	Write Enable to Output in High-Z <sup>(1)</sup>		10		10	_	15	ns	
SymbolParameter7132X55 7142X55 Com'i & Mili7132X100 7142X100 Com'i & Mili7132X100 Com'i & MiliKRParameterMin.MaxMin.MaxMin.MaxMin.MaxMin.MaxMin.MaxMin.MaxMin.MaxMin.MaxMin.Mile Cycle Time <sup>(1)</sup> GS5100msMin.Address Set-up TimeG0msMin.Mile Recovery TimeG0msMin.Mile Culd o End-of-WriteG400msMin.Mile Endol Time <sup>(1)</sup> G100msMin.Mile Endol Time <sup>(1)</sup> G30400msMin.Mile Endol Time <sup>(1)</sup> G30400msMin.Mile Endol Time <sup>(1)</sup> GG30400msMin.Mile Endol Time<	tow	Output Active from End-of-Write <sup>(1)</sup>	0	_	0		0		ns	
SymbolParameter $7142X55$ Com'l & Military $7142X10$ Com'l & MilitaryMaxMa									2692 tb	
VRITE CYCLE         S5          100          Ins           twc         Write Cycle Time <sup>(1)</sup> 55          100          Ins           tww         Address Valid to End-of-Write         400          900          Ins           tww         Address Valid to End-of-Write         400          900          Ins           tww         Address Set-up Time         00          900          Ins           twp         Write Pulse Width <sup>(4)</sup> 00          00          Ins           tww         Data Valid to End-of-Write         00          00          Ins           tww         Write Recovery Time         0          0          Ins           tww         Data Valid to End-of-Write         200          400          Ins           tww         Data Valid to End-of-Write          25          400         Ins           twx         Data Hold Time         0          30          40         Ins           twri						7142X55 Com'l &		7142X100 Com'l &		
twc         Write Cycle Time <sup>(i)</sup> 55          100          ns           tew         Chip Enable to End-of-Write         40          90          ns           taw         Address Valid to End-of-Write         40          90          ns           taw         Address Set-up Time         0          0          ns           twp         Write Pulse Width <sup>(4)</sup> 0          0          ns           twr         Write Recovery Time         0          0          ns           twr         Data Valid to End-of-Write         20          400          ns           twr         Write Recovery Time         0          10          ns           twr         Data Valid to End-of-Write         20          400          ns           twr         Data Hold Time <sup>(1)</sup> 10          ns           twr         Data Hold Time         0          30          40         ns           twr         Write Enable to Output in Hi	Symbol				IVIIII	tai y	Mili	tary		
tewChip Enable to End-of-Write4090nstawAddress Valid to End-of-Write4090nstasAddress Set-up Time00nstwpWrite Pulse Width <sup>(4)</sup> 3055nstwrWrite Recovery Time00nstwwData Valid to End-of-Write00nstwrData Valid to End-of-Write2040nstbwData Valid to End-of-Write2540nstbwData Valid to End-of-Write03040nstbwData Valid to End-of-Write3040nstbwData Valid to End-of-Write3040nstbwData Hold Time03040nstbwWrite Enable to Output in High-Z <sup>(1)</sup> 3040nstbwWrite Enable to Output in High-Z <sup>(1)</sup> 40nstbwWrite Enable to Output in High-Z <sup>(1)</sup> 40nstbwHigh-Enable to Output in High-Z <sup>(1)</sup> 40ns	Symbol	Parameter				-		-	Uni	
tAWAddress Valid to End-of-Write4090nstAsAddress Set-up Time00nstWPWrite Pulse Width <sup>(4)</sup> 3055nstWRWrite Recovery Time00nstDWData Valid to End-of-Write2040nstDWData Valid to End-of-Write2540nstDWData Valid to End-of-Write3040nstDWData Valid to End-of-Write3040nstDWData Valid to End-of-Write3040nstWZWrite Enable to Output in High-Z <sup>(1)</sup> 3040ns	-					-		-	Uni	
tas         Address Set-up Time         0          0          ns           twp         Write Pulse Width <sup>(4)</sup> 30          55          ns           twr         Write Recovery Time         0          0          ns           twr         Data Valid to End-of-Write         0          40          ns           tbw         Data Valid to End-of-Write         20          400         ns           tbr         Data Valid to End-of-Write          25          400         ns           tbr         Data Hold Time         0          300          400         ns           tbr         Data Hold Time         0          300          400         ns           twz         Write Enable to Output in High-Z <sup>(1)</sup> 300          400         ns	WRITE CYCLI				Min.	Мах.	Min.	-	<b>Uni</b> ns	
twpWrite Pulse Width <sup>(4)</sup> 3055nstwrWrite Recovery Time00nstbwData Valid to End-of-Write2040nsthzOutput High-Z Time <sup>(1)</sup> 2540nstbHData Hold Time00nstwzWrite Enable to Output in High-Z <sup>(1)</sup> 3040ns	WRITE CYCLI	Write Cycle Time <sup>(3)</sup>			<b>Min</b> . 55	Max.	<b>Min</b> . 100	Max.		
twrWrite Recovery Time00nstbwData Valid to End-of-Write2040nstHzOutput High-Z Time <sup>(1)</sup> 2540nstDHData Hold Time00nstwzWrite Enable to Output in High-Z <sup>(1)</sup> 3040ns	WRITE CYCLI twc tew	Write Cycle Time <sup>(3)</sup> Chip Enable to End-of-Write			<b>Min.</b> 55 40	Max.	Min. 100 90	Max.	ns	
tw         Data Valid to End-of-Write         20          40          ns           tHz         Output High-Z Time <sup>(1)</sup> 25          40         ns           tDH         Data Hold Time         0          0          ns           tWz         Write Enable to Output in High-Z <sup>(1)</sup> 30          40         ns	twc tew taw	Write Cycle Time <sup>(3)</sup> Chip Enable to End-of-Write Address Valid to End-of-Write			Min. 55 40 40	Max.	Min. 100 90 90	Max.	ns ns ns	
Hz       Output High-Z Time <sup>(1)</sup> 25        40       ns         tbH       Data Hold Time       0        0        10        10	twc tew taw tas	Write Cycle Time <sup>(3)</sup> Chip Enable to End-of-Write Address Valid to End-of-Write Address Set-up Time			Min. 55 40 40 0	Max.	Min. 100 90 90 0	Max.	ns ns ns	
tDH     Data Hold Time     0      0      ns       twz     Write Enable to Output in High-Z <sup>(1)</sup> 30      40     ns	INRITE CYCLI twc tew taw tas twp	Write Cycle Time <sup>(3)</sup> Chip Enable to End-of-Write Address Valid to End-of-Write Address Set-up Time Write Pulse Width <sup>(4)</sup>			Min. 55 40 40 0 30	Max.	Min. 100 90 90 0 55	Max.	ns ns	
twz Write Enable to Output in High- $Z^{(1)}$ — 30 — 40 ns	twc tew taw tas twp twr	Write Cycle Time <sup>(3)</sup> Chip Enable to End-of-Write Address Valid to End-of-Write Address Set-up Time Write Pulse Width <sup>(4)</sup> Write Recovery Time			Min. 55 40 40 0 30 0	Max.	Min. 100 90 90 0 55 0	Max.	ns ns ns ns	
	VRITE CYCLI twc tew taw tas twp twr twr tow	Write Cycle Time <sup>(3)</sup> Chip Enable to End-of-Write Address Valid to End-of-Write Address Set-up Time Write Pulse Width <sup>(4)</sup> Write Recovery Time Data Valid to End-of-Write			Min. 55 40 40 0 30 0 20	Max.	Min. 100 90 0 55 0 40	Max.	ns ns ns ns	
tow Output Active from End-of-Write <sup>(1)</sup> 0 — 0 — ns	MRITE CYCLI twc tew taw taw taw twp twr twr tbw thz	Write Cycle Time <sup>(3)</sup> Chip Enable to End-of-Write         Address Valid to End-of-Write         Address Set-up Time         Write Pulse Width <sup>(4)</sup> Write Recovery Time         Data Valid to End-of-Write         Output High-Z Time <sup>(1)</sup>			Min. 55 40 40 0 30 0 20 	Max.	Min. 100 90 0 555 0 40	Max.	ns ns ns ns ns ns	
	MRITE CYCLI twc tew taw tas twp twr twr tow thz toh	Write Cycle Time <sup>(9)</sup> Chip Enable to End-of-Write Address Valid to End-of-Write Address Set-up Time Write Pulse Width <sup>(4)</sup> Write Recovery Time Data Valid to End-of-Write Output High-Z Time <sup>(1)</sup> Data Hold Time			Min. 55 40 40 0 30 0 20  0	Max.	Min. 100 90 0 55 0 40  0	Max.	ns ns ns ns ns ns	

NOTES:

2. PLCC package only.

3. For Master/Slave combination, twc = tBAA + twP, since R/W = V<sub>IL</sub> must occur after tBAA.

4. If  $\overline{OE}$  is LOW during a R/ $\overline{W}$  controlled write cycle, the write pulse width must be the larger of twp or (twz + tow) to allow the I/O drivers to turn off data to be placed on the bus for the required tow. If  $\overline{OE}$  is High during a R/ $\overline{W}$  controlled write cycle, this requirement does not apply and the write pulse can be as short as the specified twp.

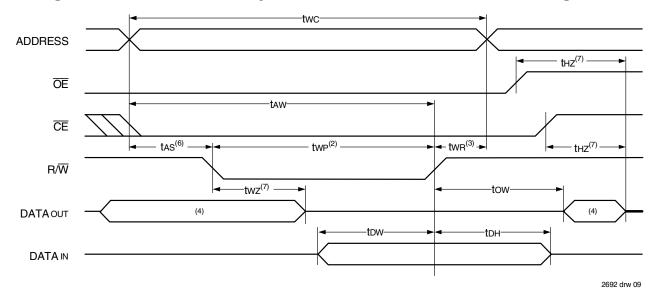
5. 'X' in part numbers indicates power rating (SA or LA).

6. Industrial temperature: for specific speeds, packages and powers contact your sales office.

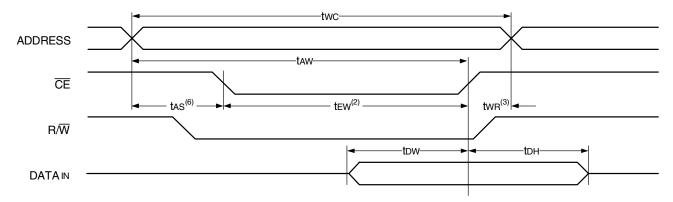
<sup>1.</sup> Transition is measured 0mV from Low or High-impedance voltage with Output Test Load (Figure 2). This parameter is guaranteed by device characterization but is not production tested.

2692 drw 10

Timing Waveform of Write Cycle No. 1, (R/W Controlled Timing)<sup>(1,5,8)</sup>



Timing Waveform of Write Cycle No. 2, (CE Controlled Timing)<sup>(1,5)</sup>



- 1.  $R/\overline{W}$  or  $\overline{CE}$  must be HIGH during all address transitions.
- 2. A write occurs during the overlap (tew or twp) of  $\overline{CE}$  = VIL and  $R\overline{IW}$  = VIL.
- 3. two is measured from the earlier of CE or R/W going HIGH to the end of the write cycle.
- 4. During this period, the I/O pins are in the output state and input signals must not be applied.
- 5. If the CE LOW transition occurs simultaneously with or after the R/W LOW transition, the outputs remain in the High-impedance state.
- 6. Timing depends on which enable signal (CE or R/W) is asserted last.
- 7. This parameter is determined be device characterization, but is not production tested. Transition is measured 0mV from steady state with the Output Test Load (Figure 2).
- 8. If  $\overline{OE}$  is LOW during a R/W controlled write cycle, the write pulse width must be the larger of twp or (twz + tow) to allow the I/O drivers to turn off data to be placed on the bus for the required tow. If  $\overline{OE}$  is HIGH during a R/W controlled write cycle, this requirement does not apply and the write pulse can be as short as the specified twp.

# AC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range<sup>(7,8)</sup>

	7132X20 <sup>(1)</sup> 7142X20 <sup>(1)</sup> Com'l Only			7132X25 <sup>(2)</sup> 7142X25 <sup>(2)</sup> Com'l, Ind & Military		7132X35 7142X35 Com'l & Military		
Symbol	Parameter	Min.	Max.	Min.	Мах.	Min.	Мах.	Unit
BUSY Timing	y (For Master IDT7132 Only)							
tbaa	BUSY Access Time from Address		20		20	—	20	ns
tBDA	BUSY Disable Time from Address	—	20	—	20	—	20	ns
tbac	BUSY Access Time from Chip Enable	—	20		20	—	20	ns
tBDC	BUSY Disable Time from Chip Enable		20		20	_	20	ns
twdd	Write Pulse to Data Delay <sup>(2)</sup>		50		50	_	60	ns
twн	Write Hold After BUSY <sup>(6)</sup>	12		15		20	—	ns
tDDD	Write Data Valid to Read Data Delay <sup>(2)</sup>		35	—	35	—	35	ns
taps	Arbitration Priority Set-up Time <sup>(3)</sup>	5		5		5	_	ns
tBDD	BUSY Disable to Valid Data <sup>(4)</sup>		25		35		35	ns
BUSY Timing	y (For Slave IDT7142 Only)							
twв	Write to BUSY Input <sup>(5)</sup>	0		0		0	—	ns
twн	Write Hold After BUSY <sup>(6)</sup>	12		15		20	—	ns
twdd	Write Pulse to Data Delay <sup>(2)</sup>		40		50	_	60	ns
todd	Write Data Valid to Read Data Delay <sup>(2)</sup>		30		35	_	35	ns
	I			1		1		2692 tbl 11;
				714 Cor	2X55 2X55 n'l & itary	7142 Con	2X100 2X100 n'I & itary	2692 tbl 11;
Symbol	Parameter			714 Cor	2X55 n'I&	7142 Con	2X100 2X100 n'l &	2692 tbl 11: Unit
,	Parameter J (For Master IDT7132 Only)			714 Cor Mil	2X55 n'I& itary	7142 Con Mili	2X100 2X100 n'I & itary	
,				714 Cor Mil	2X55 n'I& itary	7142 Con Mili	2X100 2X100 n'I & itary	
BUSY Timing	(For Master IDT7132 Only)			714 Cor Mil	2X55 n'I & itary Max.	7142 Con Mili	2X100 2X100 n'I & itary Max.	Unit
BUSY Timing	(For Master IDT7132 Only) BUSY Access Time from Address			714 Cor Mil	2X55 n'I & itary Max. 30	7142 Con Mili Min.	2X100 2X100 n'I & itary Max.	Unit
BUSY Timing tBAA tBDA	(For Master IDT7132 Only)         BUSY Access Time from Address         BUSY Disable Time from Address			714 Cor Mil Min.	2X55 n'I & itary Max. 30 30	7142 Con Mili Min.	2X100 2X100 n'l & itary Max. 50 50	Unit ns ns
BUSY Timing tBAA tBDA tBAC	(For Master IDT7132 Only)         BUSY Access Time from Address         BUSY Disable Time from Address         BUSY Access Time from Chip Enable			714 Cor Mil Min.	2X55 n'l & itary Max. 30 30 30	7142 Con Mili Min.	2X100 2X100 n'I & itary Max. 50 50 50	Unit ns ns
BUSY Timing tBAA tBDA tBAC tBDC	(For Master IDT7132 Only)         BUSY Access Time from Address         BUSY Disable Time from Address         BUSY Access Time from Chip Enable         BUSY Disable Time from Chip Enable			714 Cor Mil Min.	2X55 n'l & itary Max. 30 30 30 30 30	7142 Con Mili Min.	X100 X100 n'l & itary Max. 50 50 50 50	Unit ns ns ns
BUSY Timing tBAA tBDA tBAC tBDC tWDD	(For Master IDT7132 Only)         BUSY Access Time from Address         BUSY Disable Time from Address         BUSY Access Time from Chip Enable         BUSY Disable Time from Chip Enable         Write Pulse to Data Delay <sup>(2)</sup>			714 Cor Mil Min.	2X55 n'l & itary Max. 30 30 30 30 30	7142 Con Mili Min.	X100 X100 n'l & itary Max. 50 50 50 50	Unit ns ns ns ns
BUSY Timing tBAA tBDA tBAC tBDC tWDD tWH	(For Master IDT7132 Only)         BUSY Access Time from Address         BUSY Disable Time from Address         BUSY Access Time from Chip Enable         BUSY Disable Time from Chip Enable         Write Pulse to Data Delay <sup>(2)</sup> Write Hold After BUSY <sup>(6)</sup>			714 Cor Mil Min.	2X55 n'l & itary Max. 30 30 30 30 30 80 	7142 Con Mili Min.	X100 X100 n'l & itary Max. 50 50 50 50 120 	Unit ns ns ns ns ns
BUSY Timing tBAA tBDA tBDA tBAC tBDC tMDD tMH tDDD	(For Master IDT7132 Only)         BUSY Access Time from Address         BUSY Disable Time from Address         BUSY Access Time from Chip Enable         BUSY Disable Time from Chip Enable         Write Pulse to Data Delay <sup>(2)</sup> Write Hold After BUSY <sup>(6)</sup> Write Data Valid to Read Data Delay <sup>(2)</sup>			714 Cor Mil Min. — — — — — 20 ——	2X55 n'l & itary Max. 30 30 30 30 30 80 	7142 Con Mili Min. — — — — — 20 ——	X100 X100 n'l & itary Max. 50 50 50 50 120 	Unit ns ns ns ns ns ns ns
BUSY Timing tBAA tBDA tBAC tBDC tBDC tWD tWH tDDD tDDD tAPS tBDD	(For Master IDT7132 Only)         BUSY Access Time from Address         BUSY Disable Time from Address         BUSY Access Time from Chip Enable         BUSY Disable Time from Chip Enable         Write Pulse to Data Delay <sup>(2)</sup> Write Hold After BUSY <sup>(6)</sup> Write Data Valid to Read Data Delay <sup>(2)</sup> Arbitration Priority Set-up Time <sup>(3)</sup>			714 Cor Mil Min. — — — — — 20 ——	2X55 n'l & Max. 30 30 30 30 30 30 30 55 55 	7142 Con Mili Min. — — — — — 20 ——	X100 X100 n'l & itary Max. 50 50 50 50 50 120  100 	Unit ns ns ns ns ns ns ns ns
BUSY Timing tBAA tBDA tBAC tBDC tBDC tWD tWH tDDD tDDD tAPS tBDD	(For Master IDT7132 Only)         BUSY Access Time from Address         BUSY Disable Time from Address         BUSY Access Time from Chip Enable         BUSY Disable Time from Chip Enable         Write Pulse to Data Delay <sup>(2)</sup> Write Hold After BUSY <sup>(6)</sup> Write Data Valid to Read Data Delay <sup>(2)</sup> Arbitration Priority Set-up Time <sup>(3)</sup> BUSY Disable to Valid Data <sup>(4)</sup>			714 Cor Mil Min. — — — — — 20 ——	2X55 n'l & Max. 30 30 30 30 30 30 30 55 55 	7142 Con Mili Min. — — — — — 20 ——	X100 X100 n'l & itary Max. 50 50 50 50 50 120  100 	Unit ns ns ns ns ns ns ns ns
BUSY Timing tBAA tBDA tBDA tBDC tBDC tWD tDD tDD tDD tAPS tBDD BUSY Timing	(For Master IDT7132 Only)         BUSY Access Time from Address         BUSY Disable Time from Address         BUSY Access Time from Chip Enable         BUSY Disable Time from Chip Enable         BUSY Disable Time from Chip Enable         Write Pulse to Data Delay <sup>(2)</sup> Write Hold After BUSY <sup>(6)</sup> Write Data Valid to Read Data Delay <sup>(2)</sup> Arbitration Priority Set-up Time <sup>(3)</sup> BUSY Disable to Valid Data <sup>(4)</sup> (For Slave IDT7142 Only)			714 Cor Mil Min. — — — — 20 — 5 5	2X55 n'l & Max. 30 30 30 30 30 30 55 55 50	7142 Con Mili Min. 	X100 X100 n'l & itary Max. 50 50 50 50 50 120  100  65	Unit ns ns ns ns ns ns ns ns ns
BUSY Timing tBAA tEDA tEAC tEDC tEDC tWD tCDD tAPS tEDD BUSY Timing	(For Master IDT7132 Only)         BUSY Access Time from Address         BUSY Disable Time from Address         BUSY Access Time from Chip Enable         BUSY Disable Time from Chip Enable         Write Pulse to Data Delay <sup>(2)</sup> Write Hold After BUSY <sup>(6)</sup> Write Data Valid to Read Data Delay <sup>(2)</sup> Arbitration Priority Set-up Time <sup>(3)</sup> BUSY Disable to Valid Data <sup>(4)</sup> (For Slave IDT7142 Only)         Write to BUSY Input <sup>(5)</sup>			714 Cor Mil Min. — — — 20 — 5 5 —	2X55 n'l & Max. 30 30 30 30 30 30 30 55 55  50	7142 Con Mili Min. 	X100 X100 n'l & tary Max. 50 50 50 50 120  100 65	Unit ns ns ns ns ns ns ns ns ns ns

NOTES:

1. PLCC package only.

2. Port-to-port delay through RAM cells from the writing port to the reading port, refer to "Timing Waveform of Write with Port -to-Port Read and BUSY."

3. To ensure that the earlier of the two ports wins.

4. tbbb is a calculated parameter and is the greater of 0, twbb - twp (actual) or tbbb - tbw (actual).

5. To ensure that a write cycle is inhibited on port "B" during contention on port "A".

6. To ensure that a write cycle is completed on port "B" after contention on port "A".

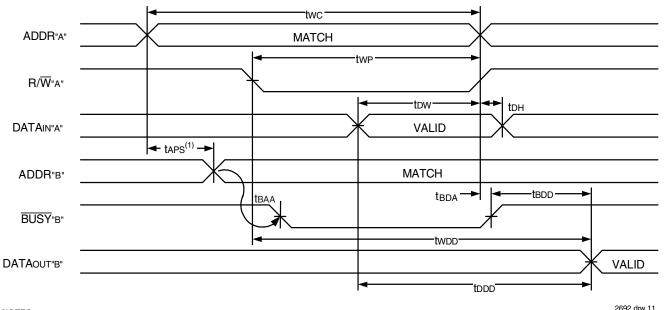
7. 'X' in part numbers indicates power rating (SA or LA).

8. Industrial temperature: for specific speeds, packages and powers contact your sales office.

2692 tbl 11b

Military, Industrial and Commercial Temperature Ranges

# Timing Waveform of Write with Port-to-Port Read and **BUSY**<sup>(2,3,4)</sup>

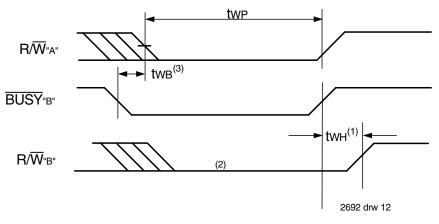


#### NOTES:

- 1. To ensure that the earlier of the two ports wins. tAPS is ignored for Slave (IDT7142).
- 2.  $\overline{CE}_{L} = \overline{CE}_{R} = VIL$
- 3.  $\overline{OE} = VIL$  for the reading port.

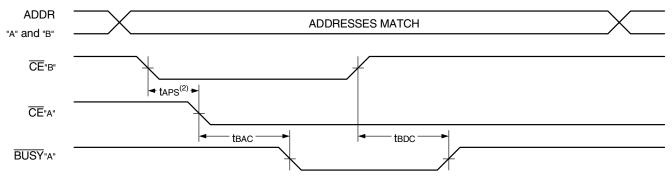
4. All timing is the same for the left and right ports. Port "A" may be either the left or right port. Port "B" is opposite from port "A".

# Timing Waveform of Write with **BUSY**<sup>(4)</sup>



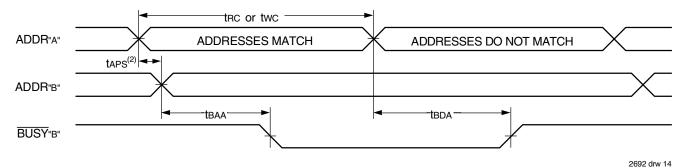
- 1. twn must be met for both BUSY Input (IDT7142, slave) or Output (IDT7132, master).
- 2. BUSY is asserted on port "B" blocking R/W"B", until BUSY"B" goes HIGH.
- 3. twb applies only to the slave version (IDT7142).
- 4. All timing is the same for the left and right ports. Port 'A' may be either the left or right port. Port "B" is opposite from port "A".

# Timing Waveform of **BUSY** Arbitration Controlled by **CE** Timing<sup>(1)</sup>



2692 drw 13

# Timing Waveform of **BUSY** Arbitration Controlled by Address Match Timing<sup>(1)</sup>



#### NOTES:

1. All timing is the same for left and right ports. Port "A" may be either left or right port. Port "B" is the opposite from port "A".

2. If taps is not satisified, the BUSY will be asserted on one side or the other, but there is no guarantee on which side BUSY will be asserted (7132 only).

# Truth Tables

## Table I. Non-Contention Read/Write Control<sup>(4)</sup>

Left or Right Port <sup>(1)</sup>			ort <sup>(1)</sup>	
R/W	Ē	ŌĒ	D0-7	Function
Х	Н	Х	Z	Port Disabled and in Power-Down Mode, ISB2 or ISB4
Х	Н	Х	Z	CER = CEL = VH, Power-Down Mode, ISB1 or ISB3
L	L	Х	DATAIN	Data on Port Written into Memory <sup>(2)</sup>
Н	L	L	DATAOUT	Data in Memory Output on Port <sup>(3)</sup>
Х	L	Н	Z	High Impedance Outputs

#### NOTES:

1. AoL - A10L  $\neq$  AOR - A10R

2. If  $\overline{\text{BUSY}}$  = L, data is not written.

3. If  $\overline{\text{BUSY}}$  = L, data may not be valid, see twod and todd timing.

4.  $H' = V_{H}, L' = V_{L}, X' = DON'T CARE, Z' = HIGH IMPEDANCE$ 

# Table II — Address **BUSY** Arbitration

	Inputs Outputs				
CEL	ĊĒr	Aol-A10l Aor-A10r	BUS YL <sup>(1)</sup>	<b>BUSY</b> R <sup>(1)</sup>	Function
Х	Х	NO MATCH	Н	Н	Normal
Н	Х	MATCH	Н	Н	Normal
Х	Н	MATCH	Н	Н	Normal
L	L	MATCH	(2)	(2)	Write Inhibit <sup>(3)</sup>

#### NOTES:

 Pins BUSYL and BUSYR are both outputs for IDT7132 (master). Both are inputs for IDT7142 (slave). BUSYX outputs on the IDT7132 are open drain, not push-pull outputs. On slaves the BUSYX input internally inhibits writes.

2692 thl 13

- 'L' if the inputs to the opposite port were stable prior to the address and enable inputs of this port. 'H' if the inputs to the opposite port became stable after the address and enable inputs of this port. If tAPS is not met, either BUSYL or BUSYR = LOW will result. BUSYL and BUSYR outputs can not be LOW simultaneously.
- Writes to the left port are internally ignored when BUSYL outputs are driving LOW regardless of actual logic level on the pin. Writes to the right port are internally ignored when BUSYR outputs are driving LOW regardless of actual logic level on the pin.

# Functional Description

The IDT7132/IDT7142 provides two ports with separate control, address and I/O pins that permit independent access for reads or writes to any location in memory. The IDT7132/IDT7142 has an automatic power down feature controlled by  $\overline{CE}$ . The  $\overline{CE}$  controls on-chip power down circuitry that permits the respective port to go into a standby mode when not selected ( $\overline{CE} = VIH$ ). When a port is enabled, access to the entire memory array is permitted.

### **Busy Logic**

Busy Logic provides a hardware indication that both ports of the RAM have accessed the same location at the same time. It also allows one of the two accesses to proceed and signals the other side that the RAM is "Busy". The BUSY pin can then be used to stall the access until the operation on the other side is completed. If a write operation has been attempted from the side that receives a busy indication, the write signal is gated internally to prevent the write from proceeding.

The use of  $\overline{\text{BUSY}}$  Logic is not required or desirable for all applications. In some cases it may be useful to logically OR the  $\overline{\text{BUSY}}$  outputs together and use any  $\overline{\text{BUSY}}$  indication as an interrupt source to flag the event of an illegal or illogical operation.

#### Military, Industrial and Commercial Temperature Ranges

The BUSY outputs on the IDT7132 RAM master are open drain type outputs and require open drain resistors to operate. If these RAMs are being expanded in depth, then the BUSY indication for the resulting array does not require the use of an external AND gate.

# Width Expansion with Busy Logic Master/Slave Arrays

When expanding an SRAM array in width while using BUSY logic, one master part is used to decide which side of the SRAM array will receive a BUSY indication, and to output that indication. Any number of slaves to be addressed in the same address range as the master, use the BUSY signal as a write inhibit signal. Thus on the IDT7132/ IDT7142 SRAMsthe BUSY pin is an output if the part is Master (IDT7132), and the BUSY pin is an input if the part is a Slave (IDT7142) as shown in Figure 3.

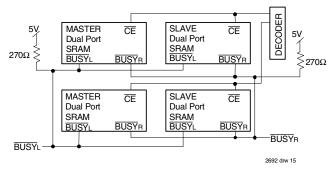
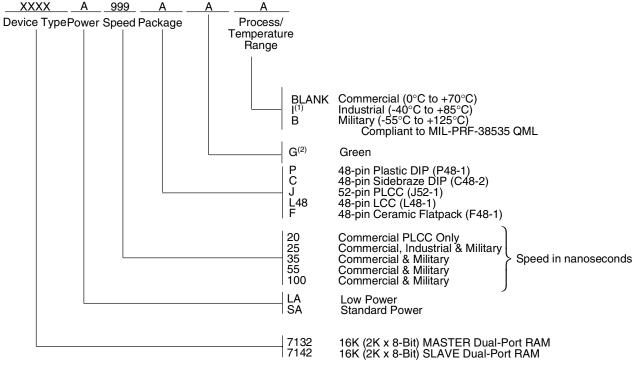


Figure 4. Busy and chip enable routing for both width and depth expansion with IDT7132 (Master) and (Slave) IDT7142 SRAMs.

If two or more master parts were used when expanding in width, a split decision could result with one master indicating BUSY on one side of the array and another master indicating BUSY on one other side of the array. This would inhibit the write operations from one port for part of a word and inhibit the write operations from the other port for the other part of the word.

The BUSY arbitration, on a Master, is based on the chip enable and address signals only. It ignores whether an access is a read or write. In a master/slave array, both address and chip enable must be valid long enough for a BUSY flag to be output from the master before the actual write pulse can be initiated with either the R/W signal or the byte enables. Failure to observe this timing can result in a glitched internal write inhibit signal and corrupted data in the slave.

## Ordering Information



2692 drw 16

#### NOTES:

- 1. Industrial temperature range is available. For specific speeds, packages and powers contact your sales office.
- 2. Green parts available. For specific speeds, packages and powers contact your local sales office.

## Datasheet Document History

03/24/99:		Initiated datasheet document history
		Converted to new format
		Cosmetic and typographical corrections
	Pages 2 and 3	Added additional notes to pin configurations
06/08/99:	-	Changed drawing format
08/26/99:	Page 14	Changed Busy Logic and Width Expansion copy
11/10/99:		Replaced IDT logo
01/12/00:	Pages 1 and 2	Moved full "Description" to page 2 and adjusted page layouts
	Page 1	Added "(LAonly)" to paragraph
	Page 2	Fixed P48-1 body package description
	Page 3	Increased storage temperature parameters
		Clarified TA parameter
	Page 4	DC Electrical parameters-changed wording from "open" to "disabled"
	Page 6	Added asteriks to Figures 1 and 3 in drw 06
	Page 14	Corrected part numbers
		Changed ±500mV to 0mV in notes
		Datasheet Document History continued on page 16

Military, Industrial and Commercial Temperature Ranges

# Datasheet Document History (cont'd)

06/11/04:	Page 6	Corrected errors in Figure 3 by changing $1250\Omega$ to $270\Omega$ and removing "or Int" and Int Clarified Industrial temp offering for 25ns
	Page 4, 7, 9, 11 & 15	Cialilieu industrial temp onening foi 250s
	Page 5	Removed $\overline{INT}$ from VoL parameter in DC Electrical Characteristics table
	Page 6	Updated AC Test Conditions Input Rise/Fall Times from 5ns to 3ns
01/17/06:	Page 1	Added green availability to features
	Page 15	Added green indicator to ordering information
	Page 16	Replaced IDT address with new
10/21/08:	Page 15	Removed "IDT" from orderable part number
09/20/10:	Page 14	Corrected BUSY description to indicate open drain outputs



*CORPORATE HEADQUARTERS* 6024 Silver Creek Valley Road San Jose, CA 95138 for SALES: 800-345-7015 or 408-284-8200 fax: 408-284-2775 www.idt.com

*for Tech Support:* 408-284-2794 DualPortHelp@idt.com

The IDT logo is a registered trademark of Integrated Device Technology, Inc.